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FSQ0465RS/RB

Green-Mode Fairchild Power Switch (FPS™) for Quasi-Resonant Operation - Low EMI and High Efficiency

Features

- Optimized for Quasi-Resonant Converters (QRC)
- Low EMI through Variable Frequency Control and AVS (Alternating Valley Switching)
- High-Efficiency through Minimum Voltage Switching
- Narrow Frequency Variation Range over Wide Load and Input Voltage Variation
- Advanced Burst-Mode Operation for Low Standby Power Consumption
- Simple Scheme for Sync Voltage Detection
- Pulse-by-Pulse Current Limit
- Various Protection Functions: Overload Protection (OLP), Over-Voltage Protection (OVP), Abnormal Over-Current Protection (AOCP), Internal Thermal Shutdown (TSD) with Hysteresis, Output Short Protection (OSP)
- Under-Voltage Lockout (UVLO) with Hysteresis
- Internal Startup Circuit
- Internal High-Voltage Sense FET (650V)
- Built-in Soft-Start (17.5ms)

Applications

- Power Supply for LCD TV and Monitor, VCR, SVR, STB, and DVD & DVD Recorder
- Adapter

Related Resources

Visit: <http://www.fairchildsemi.com/apnotes/> for:

- *AN-4134: Design Guidelines for Offline Forward Converters Using Fairchild Power Switch (FPS™)*
- *AN-4137: Design Guidelines for Offline Flyback Converters Using Fairchild Power Switch (FPS™)*
- *AN-4140: Transformer Design Consideration for Offline Flyback Converters Using Fairchild Power Switch (FPS™)*
- *AN-4141: Troubleshooting and Design Tips for Fairchild Power Switch (FPS™) Flyback Applications*
- *AN-4145: Electromagnetic Compatibility for Power Converters*
- *AN-4147: Design Guidelines for RCD Snubber of Flyback Converters*
- *AN-4148: Audible Noise Reduction Techniques for Fairchild Power Switch (FPS™) Applications*
- *AN-4150: Design Guidelines for Flyback Converters Using FSQ-Series Fairchild Power Switch (FPS™)*

Description

A Quasi-Resonant Converter (QRC) generally shows lower EMI and higher power conversion efficiency than a conventional hard-switched converter with a fixed switching frequency. The FSQ-series is an integrated Pulse-Width Modulation (PWM) controller and SenseFET specifically designed for quasi-resonant operation and Alternating Valley Switching (AVS). The PWM controller includes an integrated fixed-frequency oscillator, Under-Voltage Lockout (UVLO), Leading-Edge Blanking (LEB), optimized gate driver, internal soft-start, temperature-compensated precise current sources for a loop compensation, and self-protection circuitry. Compared with a discrete MOSFET and PWM controller solution, the FSQ-series can reduce total cost, component count, size, and weight; while simultaneously increasing efficiency, productivity, and system reliability. This device provides a basic platform for cost-effective designs of quasi-resonant switching flyback converters.

Ordering Information

Product Number	PKG. (5)	Operating Temp.	Current Limit	R _{DS(ON)} Max.	Maximum Output Power ⁽¹⁾				Replaces Devices
					230V _{AC} ±15% ⁽²⁾		85-265V _{AC}		
					Adapter ⁽³⁾	Open Frame ⁽⁴⁾	Adapter ⁽³⁾	Open Frame ⁽⁴⁾	
FSQ0465RSWDTU	TO-220F	-25 to +85°C	1.8A	2.6Ω	60W	70W	33W	48W	FSCM0465R FSDM0465RE
FSQ0465RBWDTU			3.0A						
FSQ0465RSLDTU	TO-220F(L-Forming)		1.8A						
FSQ0465RBLDTU	TO-220F(L-Forming)		3.0A						



For Fairchild's definition of Eco Status, please visit: http://www.fairchildsemi.com/company/green/rohs_green.html.

Notes:

1. The junction temperature can limit the maximum output power.
2. 230V_{AC} or 100/115V_{AC} with doubler.
3. Typical continuous power in a non-ventilated enclosed adapter measured at 50°C ambient temperature.
4. Maximum practical continuous power in an open-frame design at 50°C ambient.
5. Eco Status, RoHS.

Application Diagram

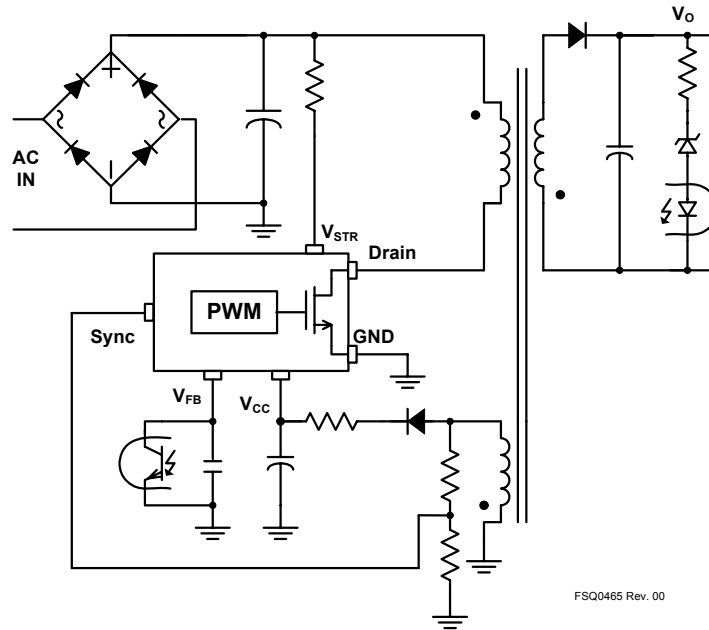


Figure 1. Typical Flyback Application

Internal Block Diagram

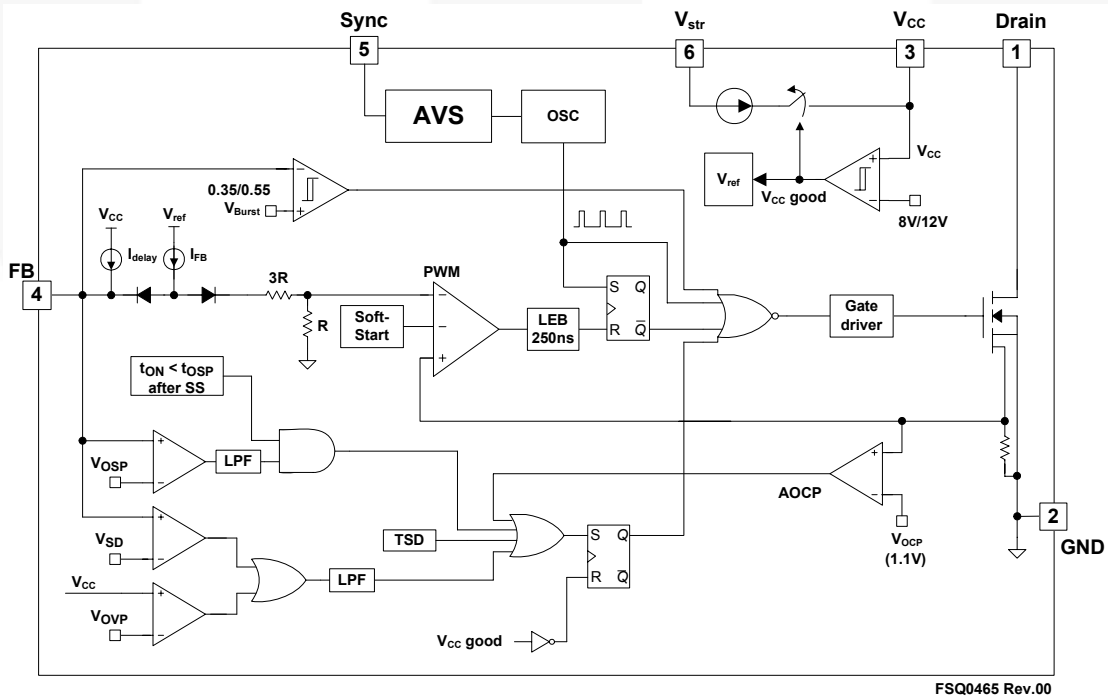


Figure 2. Internal Block Diagram

Pin Configuration

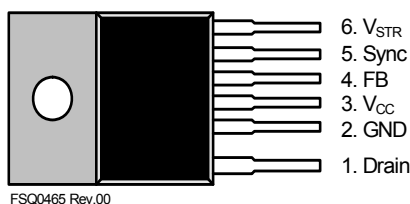


Figure 3. Pin Configuration (Top View)

Pin Definitions

Pin #	Name	Description
1	Drain	SenseFET Drain. High-voltage power SenseFET drain connection.
2	GND	Ground. This pin is the control ground and the SenseFET source.
3	V_{CC}	Power Supply. This pin is the positive supply input, providing internal operating current for both startup and steady-state operation.
4	FB	Feedback. This pin is internally connected to the inverting input of the PWM comparator. The collector of an opto-coupler is typically tied to this pin. For stable operation, a capacitor should be placed between this pin and GND. If the voltage of this pin reaches 6V, the overload protection triggers, which shuts down the FPS.
5	Sync	Sync. This pin is internally connected to the sync-detect comparator for quasi-resonant switching. In normal quasi-resonant operation, the threshold of the sync comparator is 1.2V/1.0V.
6	V_{str}	Startup. This pin is connected directly, or through a resistor, to the high-voltage DC link. At startup, the internal high-voltage current source supplies internal bias and charges the external capacitor connected to the V_{CC} pin. Once V_{CC} reaches 12V, the internal current source is disabled. It is not recommended to connect V_{str} and Drain together.

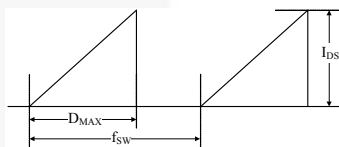
Absolute Maximum Ratings

Stresses exceeding the absolute maximum ratings may damage the device. The device may not function or be operable above the recommended operating conditions and stressing the parts to these levels is not recommended. In addition, extended exposure to stresses above the recommended operating conditions may affect device reliability. The absolute maximum ratings are stress ratings only. $T_A = 25^\circ\text{C}$, unless otherwise specified.

Symbol	Parameter	Min.	Max.	Unit
V_{str}	V_{str} Pin Voltage	500		V
V_{DS}	Drain Pin Voltage	650		V
V_{CC}	Supply Voltage		20	V
V_{FB}	Feedback Voltage Range	-0.3	13.0	V
V_{Sync}	Sync Pin Voltage	-0.3	13.0	V
I_{DM}	Drain Current Pulsed		9.6	A
I_{DSW}	Continuous Drain Switching Current ⁽⁶⁾	$T_C = 25^\circ\text{C}$		4.0 A
E_{AS}	Single Pulsed Avalanche Energy ⁽⁷⁾		120	mJ
P_D	Total Power Dissipation ($T_C=25^\circ\text{C}$)		45	W
T_J	Operating Junction Temperature	Internally limited		$^\circ\text{C}$
T_A	Operating Ambient Temperature	-25	+85	$^\circ\text{C}$
T_{STG}	Storage Temperature	-55	+150	$^\circ\text{C}$
ESD	Human Body Model, JESD22-A114	2.0		kV
	Charged Device Model, JESD22-C101	2.0		kV

Notes:

6. Repetitive peak switching current when inductor load is assumed: limited by maximum duty and maximum junction temperature.



7. $L=14\text{mH}$, starting $T_J=25^\circ\text{C}$.

Thermal Impedance

$T_A = 25^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	Package	Value	Unit
θ_{JA}	Junction-to-Ambient Thermal Resistance ⁽⁸⁾	TO-220F-6L	50	$^\circ\text{C/W}$
θ_{JC}	Junction-to-Case Thermal Resistance ⁽⁹⁾		2.8	$^\circ\text{C/W}$

Notes:

8. Free-standing with no heat-sink under natural convection.

9. Infinite cooling condition - refer to the SEMI G30-88.

Electrical Characteristics

$T_A = 25^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
SENSEFET SECTION						
BV_{DSS}	Drain Source Breakdown Voltage	$V_{CC} = 0V, I_D = 100\mu A$	650			V
I_{DSS}	Zero-Gate-Voltage Drain Current	$V_{DS} = 560V$			250	μA
$R_{DS(on)}$	Drain-Source On-State Resistance	$T_J = 25^\circ\text{C}, I_D = 0.5A$		2.2	2.6	Ω
C_{OSS}	Output Capacitance	$V_{GS} = 0V, V_{DS} = 25V, f = 1\text{MHz}$		60		pF
$t_{d(on)}$	Turn-On Delay Time	$V_{DD} = 350V, I_D = 25\text{mA}$		12		ns
t_r	Rise Time	$V_{DD} = 350V, I_D = 25\text{mA}$		20		ns
$t_{d(off)}$	Turn-Off Delay Time	$V_{DD} = 350V, I_D = 25\text{mA}$		30		ns
t_f	Fall Time	$V_{DD} = 350V, I_D = 25\text{mA}$		16		ns
CONTROL SECTION						
$t_{ON,MAX}$	Maximum On Time	$T_J = 25^\circ\text{C}$	8.8	10.0	11.2	μs
t_B	Blanking Time	$T_J = 25^\circ\text{C}, V_{sync} = 5V$	13.5	15.0	16.5	μs
t_W	Detection Time Window	$T_J = 25^\circ\text{C}, V_{sync} = 0V$		6.0		μs
f_S	Initial Switching Frequency		59.6	66.7	75.8	kHz
Δf_S	Switching Frequency Variation ⁽¹¹⁾	$-25^\circ\text{C} < T_J < 85^\circ\text{C}$		± 5	± 10	%
t_{AVS}	AVS Triggering Threshold ⁽¹¹⁾	On Time	at $V_{IN} = 240V_{DC}, L_m = 360\mu H$ (AVS triggered when $V_{AVS} >$ spec. and $t_{AVS} <$ spec.)		4.0	μs
V_{AVS}		Feedback Voltage		1.2	V	
t_{SW}	Switching Time Variance by AVS ⁽¹¹⁾	Sync = 500kHz sine input $V_{FB} = 1.2V, t_{ON} = 4.0\mu s$	13.5		20.5	μs
I_{FB}	Feedback Source Current	$V_{FB} = 0V$	700	900	1100	μA
D_{MIN}	Minimum Duty Cycle	$V_{FB} = 0V$			0	%
V_{START}	UVLO Threshold Voltage		11	12	13	V
V_{STOP}		After turn-on	7	8	9	V
$t_{S/S}$	Internal Soft-Start Time	With free-running frequency		17.5		ms
V_{OVP}	Over-Voltage Protection		18	19	20	V
BURST-MODE SECTION						
V_{BURH}	Burst-Mode Voltages	$T_J = 25^\circ\text{C}, t_{PD} = 200\text{ns}^{(10)}$	0.45	0.55	0.65	V
V_{BURL}			0.25	0.35	0.45	V
Hysteresis				200		mV

Continued on the following page...

Electrical Characteristics (Continued)

 $T_A = 25^\circ\text{C}$ unless otherwise specified.

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit	
PROTECTION SECTION							
I_{LIMIT}	Peak Current Limit of FSQ0465RS	$T_J = 25^\circ\text{C}$, $di/dt = 480\text{mA}/\mu\text{s}$	1.6	1.8	2.0	A	
I_{LIMIT}	Peak Current Limit of FSQ0465RB	$T_J = 25^\circ\text{C}$, $di/dt = 370\text{mA}/\mu\text{s}$	2.64	3.00	3.36	A	
V_{SD}	Shutdown Feedback Voltage	$V_{CC} = 15\text{V}$	5.5	6.0	6.5	V	
I_{DELAY}	Shutdown Delay Current	$V_{FB} = 5\text{V}$	4	5	6	μA	
t_{LEB}	Leading-Edge Blanking Time ⁽¹¹⁾			250		ns	
t_{OSP}	Output Short Protection ⁽¹¹⁾	Threshold Time	$T_J = 25^\circ\text{C}$ OSP triggered when $t_{ON} < t_{OSP}$, $V_{FB} > V_{OSP}$ and lasts longer than t_{OSP_FB}		1.2	1.4	μs
V_{OSP}		Threshold Feedback Voltage		1.8	2.0		V
t_{OSP_FB}		Feedback Blanking Time		2.0	2.5	3.0	μs
T_{SD}	Thermal Shutdown ⁽¹¹⁾	Shutdown Temperature	+125	+140	+155	$^\circ\text{C}$	
Hys		Hysteresis		+60			
SYNC SECTION							
V_{SH1}	Sync Threshold Voltage 1	$V_{CC} = 15\text{V}$, $V_{FB} = 2\text{V}$	1.0	1.2	1.4	V	
V_{SL1}			0.8	1.0	1.2		
t_{sync}	Sync Delay Time ⁽¹¹⁾⁽¹²⁾			230		ns	
V_{SH2}	Sync Threshold Voltage 2	$V_{CC} = 15\text{V}$, $V_{FB} = 2\text{V}$	4.3	4.7	5.1	V	
V_{SL2}			4.0	4.4	4.8		
V_{CLAMP}	Low Clamp Voltage	$I_{SYNC_MAX} = 800\mu\text{A}$, $I_{SYNC_MIN} = 50\mu\text{A}$	0.0	0.4	0.8	V	
TOTAL DEVICE SECTION							
I_{OP}	Operating Supply Current	$V_{CC} = 13\text{V}$	1	3	5	mA	
I_{START}	Start Current	$V_{CC} = 10\text{V}$ (before V_{CC} reaches V_{START})	350	450	550	μA	
I_{CH}	Startup Charging Current	$V_{CC} = 0\text{V}$, $V_{STR} = \text{minimum } 50\text{V}$	0.65	0.85	1.00	mA	
V_{STR}	Minimum V_{STR} Supply Voltage			26		V	

Notes:

10. Propagation delay in the control IC.
11. Guaranteed by design; not tested in production.
12. Includes gate turn-on time.

Comparison Between FSDM0x65RNB and FSQ-Series

Function	FSDM0x65RE	FSQ-Series	FSQ-Series Advantages
Operation Method	Constant Frequency PWM	Quasi-Resonant Operation	<ul style="list-style-type: none"> ■ Improved efficiency by valley switching ■ Reduced EMI noise ■ Reduced components to detect valley point
EMI Reduction	Frequency Modulation	Reduced EMI Noise	<ul style="list-style-type: none"> ■ Valley Switching ■ Inherent Frequency Modulation ■ Alternate Valley Switching
Hybrid Control		CCM or AVS Based on Load and Input Condition	<ul style="list-style-type: none"> ■ Improves efficiency by introducing hybrid control
Burst-Mode Operation	Burst-Mode Operation	Advanced Burst-Mode Operation	<ul style="list-style-type: none"> ■ Improved standby power by advanced burst-mode
Strong Protections	OLP, OVP	OLP, OVP, AOCP, OSP	<ul style="list-style-type: none"> ■ Improved reliability through precise AOCP ■ Improved reliability through precise OSP
TSD	145°C without Hysteresis	140°C with 60°C Hysteresis	<ul style="list-style-type: none"> ■ Stable and reliable TSD operation ■ Converter temperature range

Typical Performance Characteristics

These characteristic graphs are normalized at $T_A = 25^\circ\text{C}$.

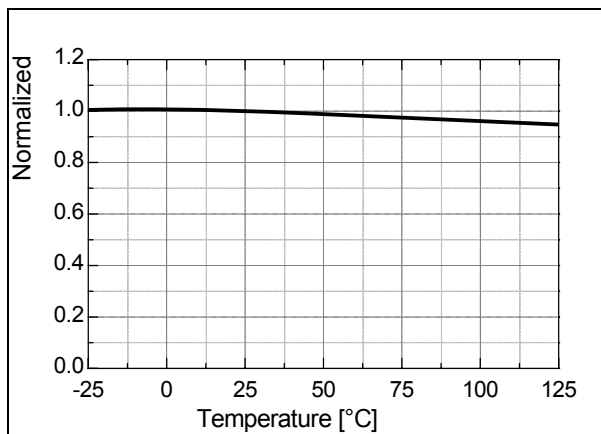


Figure 4. Operating Supply Current (I_{OP}) vs. T_A

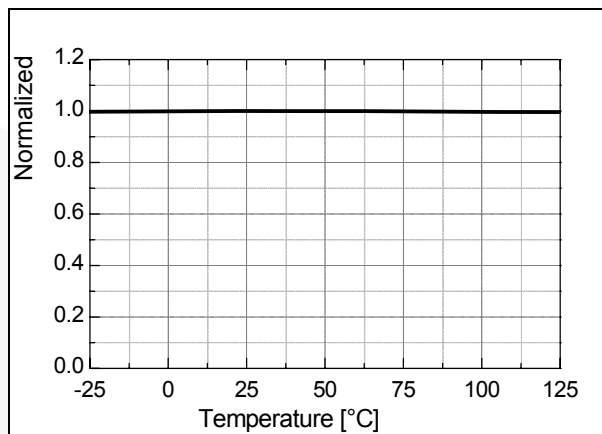


Figure 5. UVLO Start Threshold Voltage (V_{START}) vs. T_A

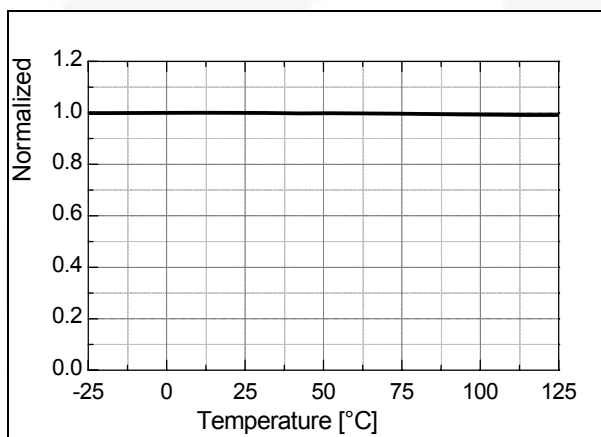


Figure 6. UVLO Stop Threshold Voltage (V_{STOP}) vs. T_A

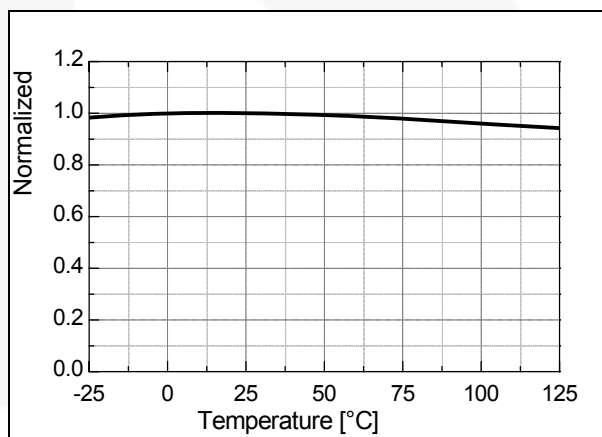


Figure 7. Startup Charging Current (I_{CH}) vs. T_A

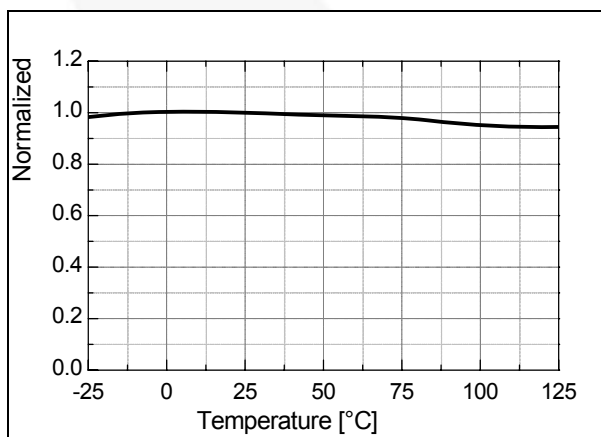


Figure 8. Initial Switching Frequency (f_S) vs. T_A

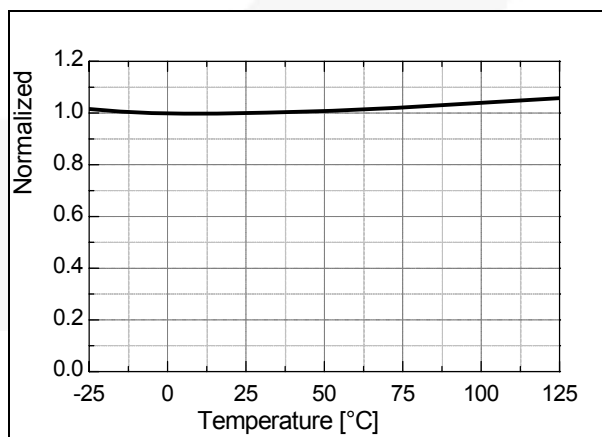


Figure 9. Maximum On Time ($t_{ON,MAX}$) vs. T_A

Typical Performance Characteristics (Continued)

These characteristic graphs are normalized at $T_A = 25^\circ\text{C}$.

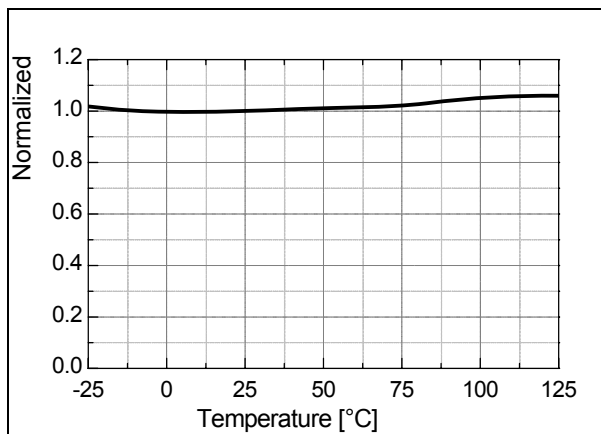


Figure 10. Blanking Time (t_B) vs. T_A

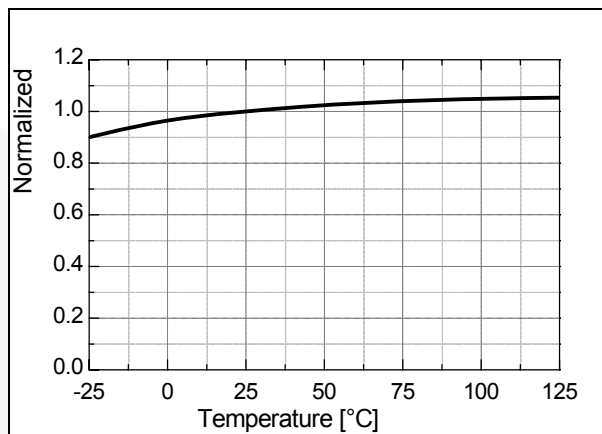


Figure 11. Feedback Source Current (I_{FB}) vs. T_A

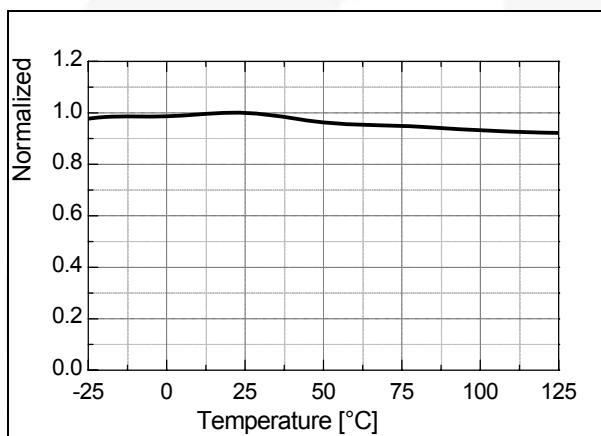


Figure 12. Shutdown Delay Current (I_{DELAY}) vs. T_A

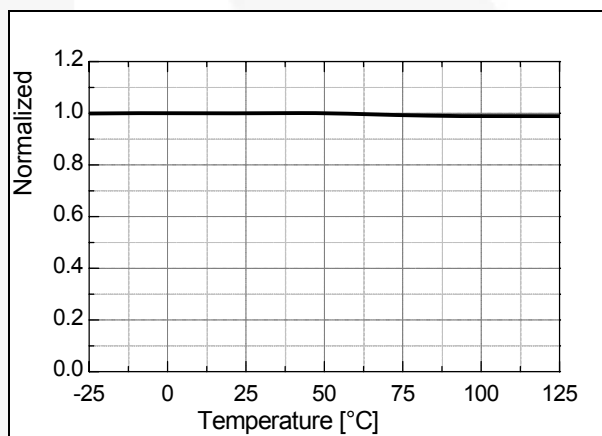


Figure 13. Burst-Mode High Threshold Voltage (V_{burh}) vs. T_A

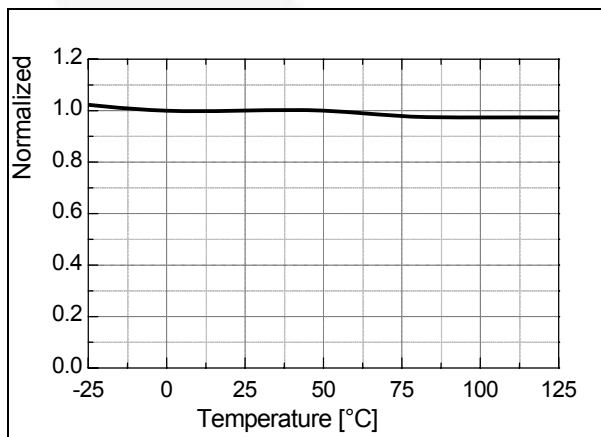


Figure 14. Burst-Mode Low Threshold Voltage (V_{burl}) vs. T_A

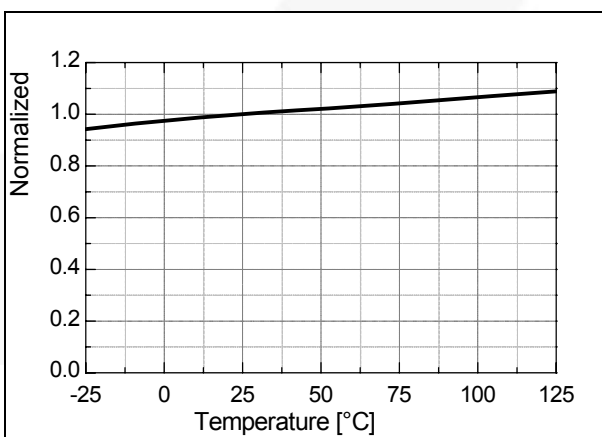


Figure 15. Peak Current Limit (I_{LIM}) vs. T_A

Typical Performance Characteristics (Continued)

These characteristic graphs are normalized at $T_A = 25^\circ\text{C}$.

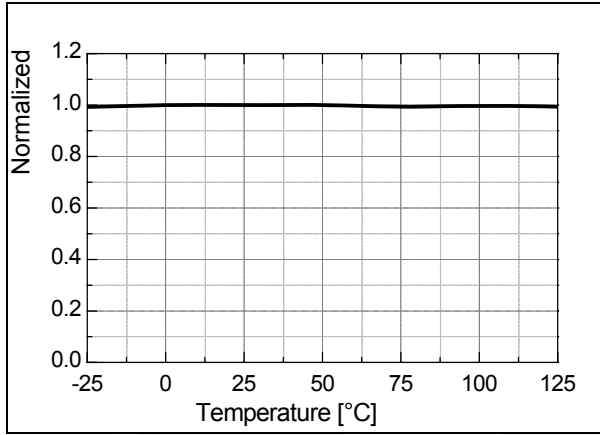


Figure 16. Sync High Threshold Voltage 1 (V_{SH1}) vs. T_A

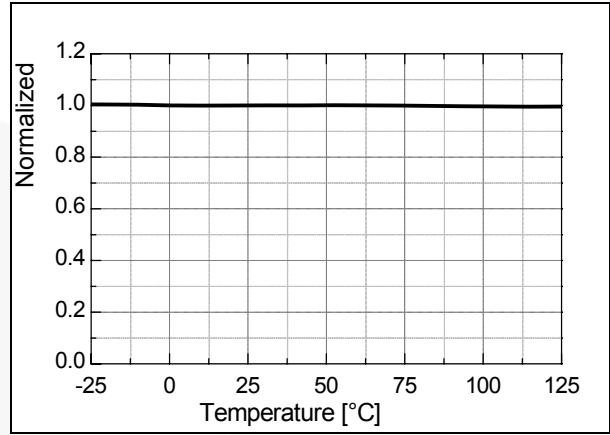


Figure 17. Sync Low Threshold Voltage 1 (V_{SL1}) vs. T_A

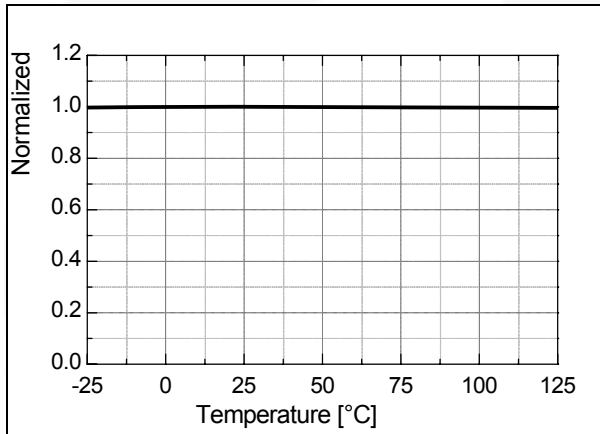


Figure 18. Shutdown Feedback Voltage (V_{SD}) vs. T_A

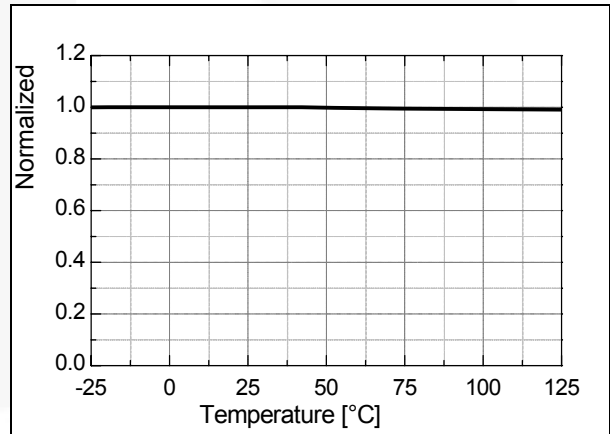


Figure 19. Over-Voltage Protection (V_{OV}) vs. T_A

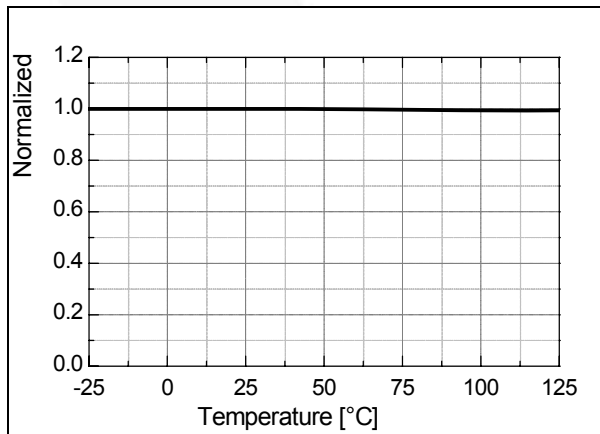


Figure 20. Sync High Threshold Voltage 2 (V_{SH2}) vs. T_A

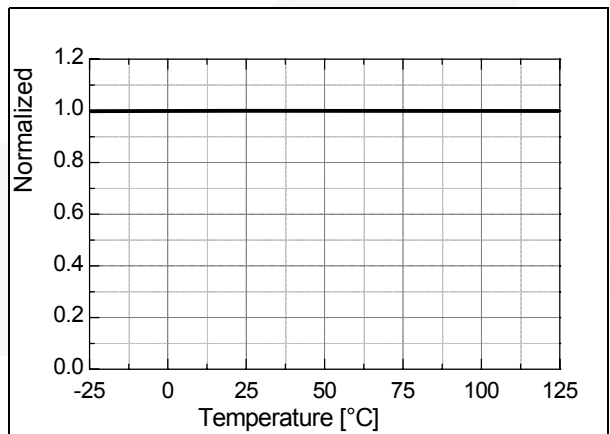


Figure 21. Sync Low Threshold Voltage 2 (V_{SL2}) vs. T_A

The switching frequency is the combination of blank time (t_B) and detection time window (t_W). In case of a heavy load, the sync voltage remains flat after t_B and waits for valley detection during t_W . This leads to a low switching frequency not suitable for heavy loads. To correct this drawback, additional timing is used. The timing conditions are described in Figures 25, 26, and 27. When the V_{sync} remains flat higher than 4.4V at the end of t_B which is instant t_x , the next switching cycle starts after internal delay time from t_x . In the second case, the next switching occurs on the valley when the V_{sync} goes below 4.4V within t_B . Once V_{sync} detects the first valley in t_B , the other switching cycle follows classical QRC operation.

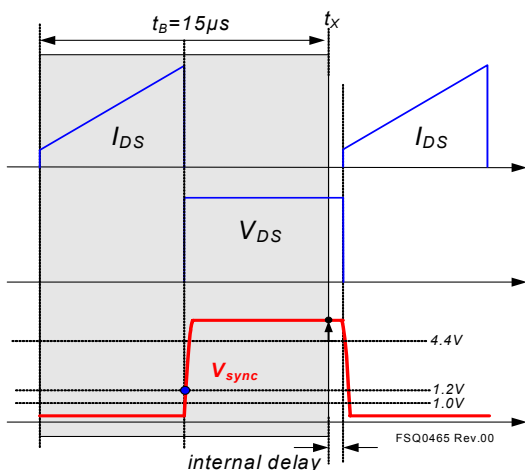


Figure 25. $V_{sync} > 4.4V$ at t_x

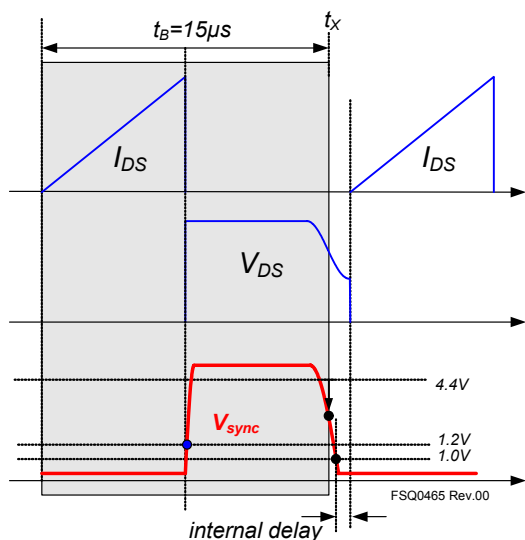


Figure 26. $V_{sync} < 4.4V$ at t_x

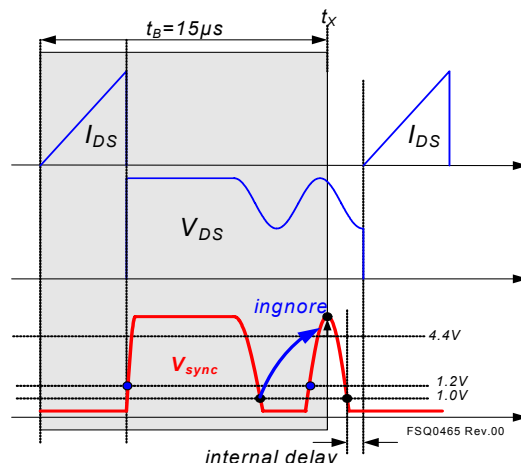


Figure 27. After V_{sync} Finds First Valley

4. Protection Circuits: The FSQ-series has several self-protective functions, such as Overload Protection (OLP), Abnormal Over-Current Protection (AOCP), Over-Voltage Protection (OVP), and Thermal Shutdown (TSD). All the protections are implemented as auto-restart mode. Once the fault condition is detected, switching is terminated and the SenseFET remains off. This causes V_{CC} to fall. When V_{CC} falls down to the Under-Voltage Lockout (UVLO) stop voltage of 8V, the protection is reset and the startup circuit charges the V_{CC} capacitor. When the V_{CC} reaches the start voltage of 12V, normal operation resumes. If the fault condition is not removed, the SenseFET remains off and V_{CC} drops to stop voltage again. In this manner, the auto-restart can alternately enable and disable the switching of the power SenseFET until the fault condition is eliminated. Because these protection circuits are fully integrated into the IC without external components, reliability is improved without increasing cost.

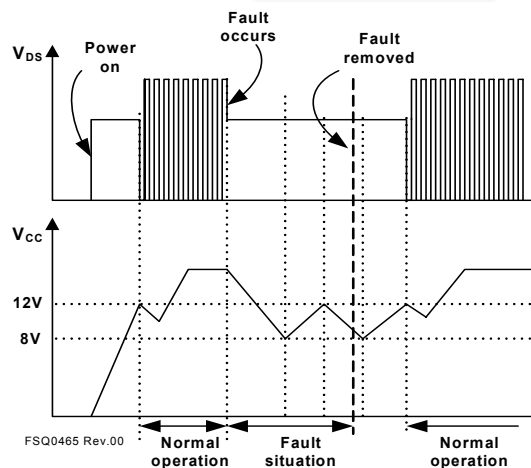


Figure 28. Auto Restart Protection Waveforms

4.1 Overload Protection (OLP): Overload is defined as the load current exceeding its normal level due to an unexpected abnormal event. In this situation, the protection circuit should trigger to protect the SMPS. However, even when the SMPS is in the normal operation, the overload protection circuit can be triggered during the load transition. To avoid this undesired operation, the overload protection circuit is designed to trigger only after a specified time to determine whether it is a transient situation or a true overload situation. Because of the pulse-by-pulse current limit capability, the maximum peak current through the SenseFET is limited, and therefore the maximum input power is restricted with a given input voltage. If the output consumes more than this maximum power, the output voltage (V_O) decreases below the set voltage. This reduces the current through the optocoupler LED, which also reduces the optocoupler transistor current, thus increasing the feedback voltage (V_{FB}). If V_{FB} exceeds 2.5V, D1 is blocked and the 5 μ A current source starts to charge C_B slowly up to V_{CC} . In this condition, V_{FB} continues increasing until it reaches 6V, when the switching operation is terminated, as shown in Figure 29. The delay time for shutdown is the time required to charge C_{FB} from 2.5V to 6V with 5 μ A. A 20 ~ 50ms delay time is typical for most applications.

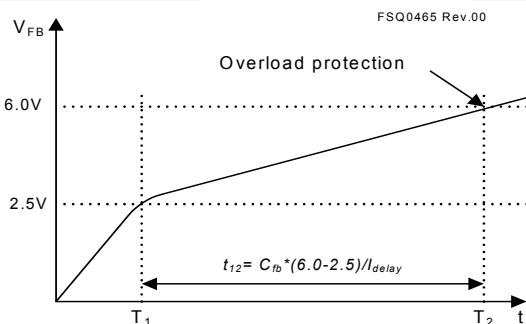


Figure 29. Overload Protection

4.2 Abnormal Over-Current Protection (AOCP): When the secondary rectifier diodes or the transformer pins are shorted, a steep current with extremely high di/dt can flow through the SenseFET during the LEB time. Even though the FSQ-series has overload protection, it is not enough to protect the FSQ-series in that abnormal case, since severe current stress is imposed on the SenseFET until OLP triggers. The FSQ-series has an internal AOCP circuit shown in Figure 30. When the gate turn-on signal is applied to the power SenseFET, the AOCP block is enabled and monitors the current through the sensing resistor. The voltage across the resistor is compared with a preset AOCP level. If the sensing resistor voltage is greater than the AOCP level, the set signal is applied to the latch, resulting in the shutdown of the SMPS.

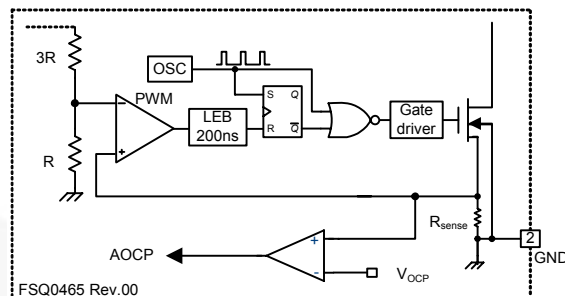


Figure 30. Abnormal Over-Current Protection

4.3 Output-Short Protection (OSP): If the output is shorted, steep current with extremely high di/dt can flow through the SenseFET during the LEB time. Such a steep current brings high voltage stress on the drain of SenseFET when turned off. To protect the device from such an abnormal condition, OSP is included in the FSQ-series. It is comprised of detecting V_{FB} and SenseFET turn-on time. When the V_{FB} is higher than 2V and the SenseFET turn-on time is lower than 1.2 μ s, the FPS recognizes this condition as an abnormal error and shuts down PWM switching until V_{CC} reaches V_{start} again. An abnormal condition output short is shown in Figure 31.

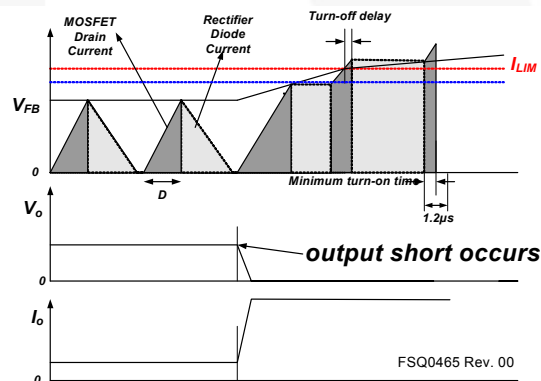


Figure 31. Output Short Waveforms

4.4 Over-Voltage Protection (OVP): If the secondary side feedback circuit malfunctions or a solder defect causes an opening in the feedback path, the current through the optocoupler transistor becomes almost zero. Then, V_{fb} climbs up in a similar manner to the overload situation, forcing the preset maximum current to be supplied to the SMPS until overload protection is activated. Because more energy than required is provided to the output, the output voltage may exceed the rated voltage before overload protection is activated, resulting in the breakdown of the devices in the secondary side. To prevent this situation, an over-voltage protection (OVP) circuit is employed. In general, V_{CC} is proportional to the output voltage and the FSQ-series uses V_{CC} instead of directly monitoring the output voltage. If V_{CC} exceeds 19V, an OVP circuit is activated,

resulting in the termination of the switching operation. To avoid undesired activation of OVP during normal operation, V_{CC} should be designed below 19V.

4.5 Thermal Shutdown with Hysteresis (TSD): The SenseFET and the control IC are built in one package. This enables the control IC to detect the abnormally high temperature of the SenseFET. If the temperature exceeds approximately 140°C, the thermal shutdown triggers IC shutdown. The IC recovers its operation when the junction temperature decreases 60°C from TSD temperature and V_{CC} reaches startup voltage (V_{start}).

5. Soft-Start: The FPS has an internal soft-start circuit that increases PWM comparator inverting input voltage with the SenseFET current slowly after it starts up. The typical soft-start time is 17.5ms. The pulse width to the power switching device is progressively increased to establish the correct working conditions for transformers, inductors, and capacitors. The voltage on the output capacitors is progressively increased with the intention of smoothly establishing the required output voltage. This mode helps prevent transformer saturation and reduces stress on the secondary diode during startup.

6. Burst Operation: To minimize power dissipation in standby mode, the FPS enters burst-mode operation. As the load decreases, the feedback voltage decreases. As shown in Figure 32, the device automatically enters burst-mode when the feedback voltage drops below V_{BURL} (350mV). At this point, switching stops and the output voltages start to drop at a rate dependent on standby current load. This causes the feedback voltage to rise. Once it passes V_{BURH} (550mV), switching resumes. The feedback voltage then falls and the process repeats. Burst-mode operation alternately enables and disables switching of the power SenseFET, thereby reducing switching loss in standby mode.

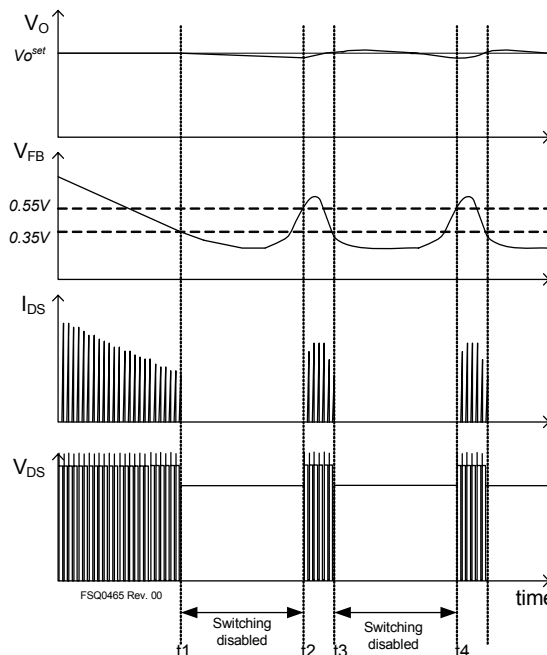


Figure 32. Waveforms of Burst Operation

7. Switching Frequency Limit: To minimize switching loss and Electromagnetic Interference (EMI), the MOSFET turns on when the drain voltage reaches its minimum value in quasi-resonant operation. However, this causes switching frequency to increase at light load conditions. As the load decreases or input voltage increases, the peak drain current diminishes and the switching frequency increases. This results in severe switching losses at light-load condition, as well as intermittent switching and audible noise. These problems create limitations for the quasi-resonant converter topology in a wide range of applications.

To overcome these problems, FSQ-series employs a frequency-limit function, as shown in Figures 33 and Figure 34. Once the SenseFET is turned on, the next turn-on is prohibited during the blanking time (t_B). After the blanking time, the controller finds the valley within the detection time window (t_W) and turns on the MOSFET, as shown in Figures 33 and Figure 34 (Cases A, B, and C). If no valley is found during t_W , the internal SenseFET is forced to turn on at the end of t_W (Case D). Therefore, the devices have a minimum switching frequency of 48kHz and a maximum switching frequency of 67kHz.

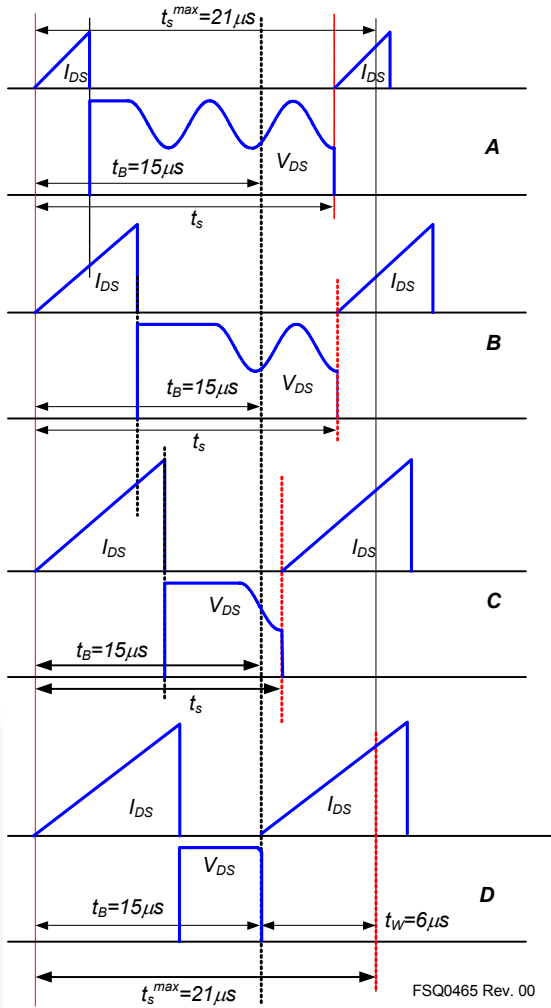


Figure 33. QRC Operation with Limited Frequency

8. AVS (Alternating Valley Switching): Due to the quasi-resonant operation with limited frequency, the switching frequency varies depending on input voltage, load transition, and so on. At high input voltage, the switching on time is relatively small compared to low input voltage. The input voltage variance is small and the switching frequency modulation becomes small. To improve the EMI performance, AVS is enabled when input voltage is high and the switching on time is small.

Internally, quasi-resonant operation is divided into two categories; one is first-valley switching and the other is second-valley switching after blanking time. In AVS, two successive occurrences of first-valley switching and the other two successive occurrences of second-valley switching is alternatively selected to maximize frequency modulation. As depicted in Figure 34, the switching frequency hops when the input voltage is high. The internal timing diagram of AVS is described in Figure 35.

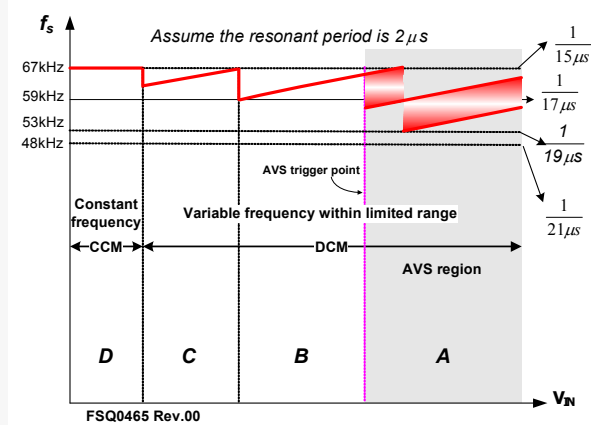


Figure 34. Switching Frequency Range

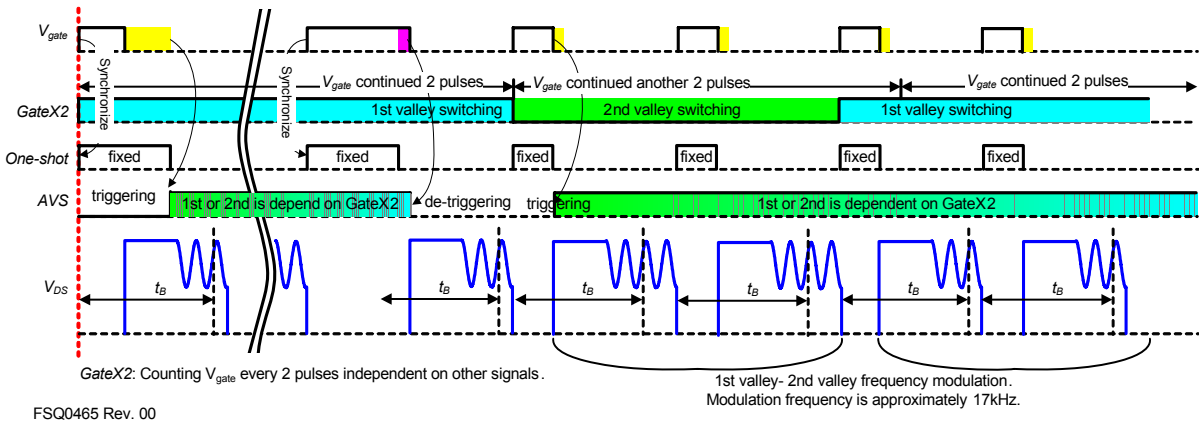


Figure 35. Alternating Valley Switching (AVS)

PCB Layout Guide

Due to the combined scheme, FPS shows better noise immunity than conventional PWM controller and MOSFET discrete solutions. Furthermore, internal drain current sense eliminates noise generation caused by a sensing resistor. There are some recommendations for PCB layout to enhance noise immunity and suppress the noise inevitable in power-handling components.

There are typically two grounds in the conventional SMPS: power ground and signal ground. The power ground is the ground for primary input voltage and power, while the signal ground is ground for PWM controller. In FPS, those two grounds share the same pin, GND. Normally the separate grounds do not share the same trace and meet only at one point, the GND pin. More, wider patterns for both grounds are good for large currents by decreasing resistance.

Capacitors at the V_{CC} and FB pins should be as close as possible to the corresponding pins to avoid noise from the switching device. Sometimes Mylar® or ceramic capacitors with electrolytic for V_{CC} is better for smooth operation. The ground of these capacitors needs to connect to the signal ground (not power ground).

The cathode of the snubber diode should be close to the Drain pin to minimize stray inductance. The Y-capacitor between primary and secondary should be directly connected to the power ground of DC link to maximize surge immunity.

Because the voltage range of feedback and sync line is small, it is affected by the noise of the drain pin. Those traces should not draw across or close to the drain line.

When the heat sink is connected to the ground, it should be connected to the power ground. If possible, avoid using jumper wires for power ground and drain.



Figure 36. Recommended PCB Layout

Mylar® is a registered trademark of DuPont Teijin Films.

Typical Application Circuit

Application	FPS™ Device	Input Voltage Range	Rated Output Power	Output Voltage (Maximum Current)
LCD Monitor Power Supply	FSQ0465RS	85-265V _{AC}	40W	5.0V (2.0A) 13V (2.3A)

Features

- Average efficiency of 25%, 50%, 75%, and 100% load conditions is higher than 80% at universal input
- Low standby mode power consumption (<1W at 230V_{AC} input and 0.5W load)
- Reduce EMI noise through valley switching operation
- Enhanced system reliability through various protection functions
- Internal soft-start (17.5ms)

Key Design Notes

- The delay time for overload protection is designed to be about 23ms with C105 of 33nF. If faster/slower triggering of OLP is required, C105 can be changed to a smaller/larger value (e.g. 100nF for 70ms).
- The input voltage of V_{Sync} must be between 4.7V and 8V just after MOSFET turn-off to guarantee hybrid control and to avoid OVP triggering during normal operation.
- The SMD-type 100nF capacitor must be placed as close as possible to V_{CC} pin to avoid malfunction by abrupt pulsating noises and to improve surge immunity.

1. Schematic

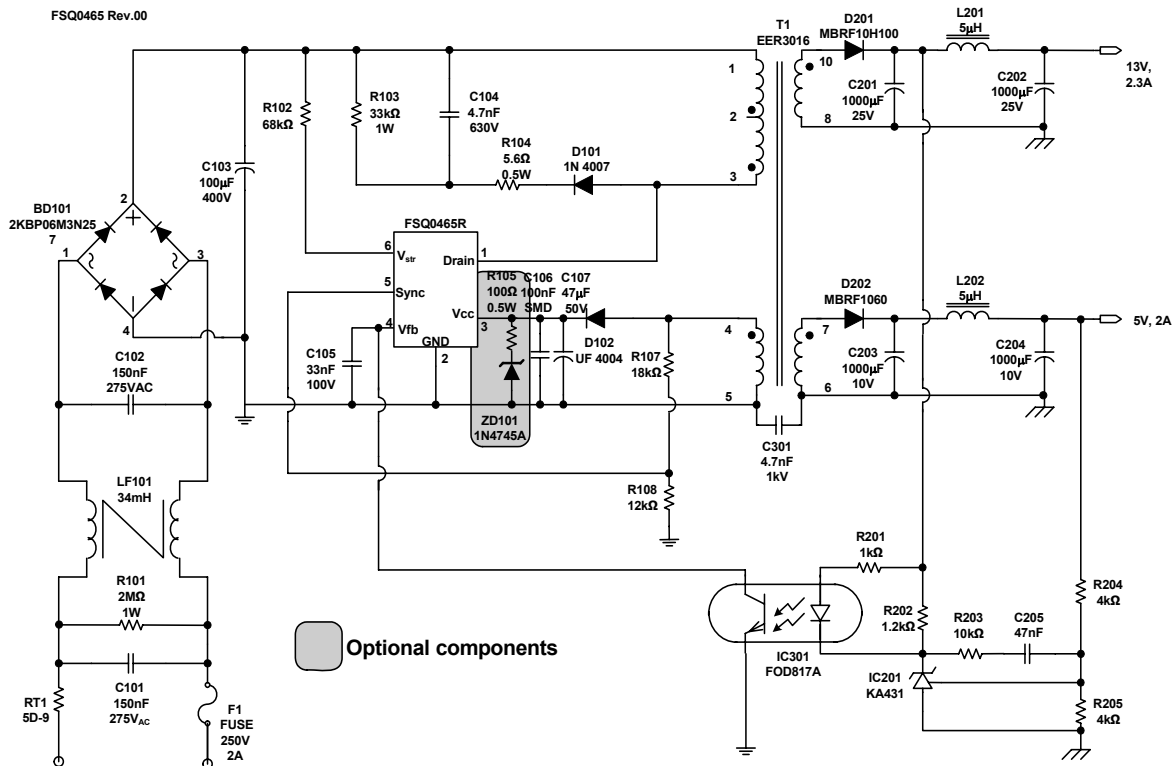


Figure 37. Demo Circuit of FSQ0465RS

2. Transformer

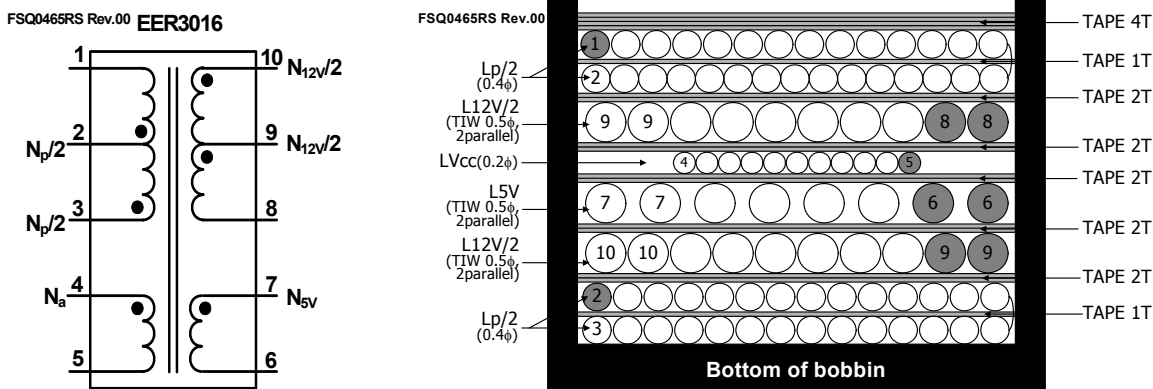


Figure 38. Transformer Schematic Diagram of FSQ0465RS

3. Winding Specification

Position	No	Pin (s→f)	Wire	Turns	Winding Method
↑ Top ↓ Bottom	Insulation: Polyester Tape t = 0.025mm, Four Layers				
	N _{p/2}	2 → 1	0.4φ × 1	22	Two-Layer Solenoid Winding
	Insulation: Polyester Tape t = 0.025mm, Two Layers				
	N _{12v/2}	9 → 8	0.5φ × 2(TIW)	5	Center Solenoid Winding
	Insulation: Polyester Tape t = 0.025mm, Two Layers				
	N _a	4 → 5	0.15φ × 1	11	Center Solenoid Winding
	Insulation: Polyester Tape t = 0.025mm, Two Layers				
	N _{5v}	7 → 6	0.5φ × 2(TIW)	4	Center Solenoid Winding
	Insulation: Polyester Tape t = 0.025mm, Two Layers				
N _{12v/2}	10 → 9	0.5φ × 2(TIW)	5	Center Solenoid Winding	
Insulation: Polyester Tape t = 0.025mm, Two Layers					
N _{p/2}	3 → 2	0.4φ × 1	32	Two-Layer Solenoid Winding	

4. Electrical Characteristics

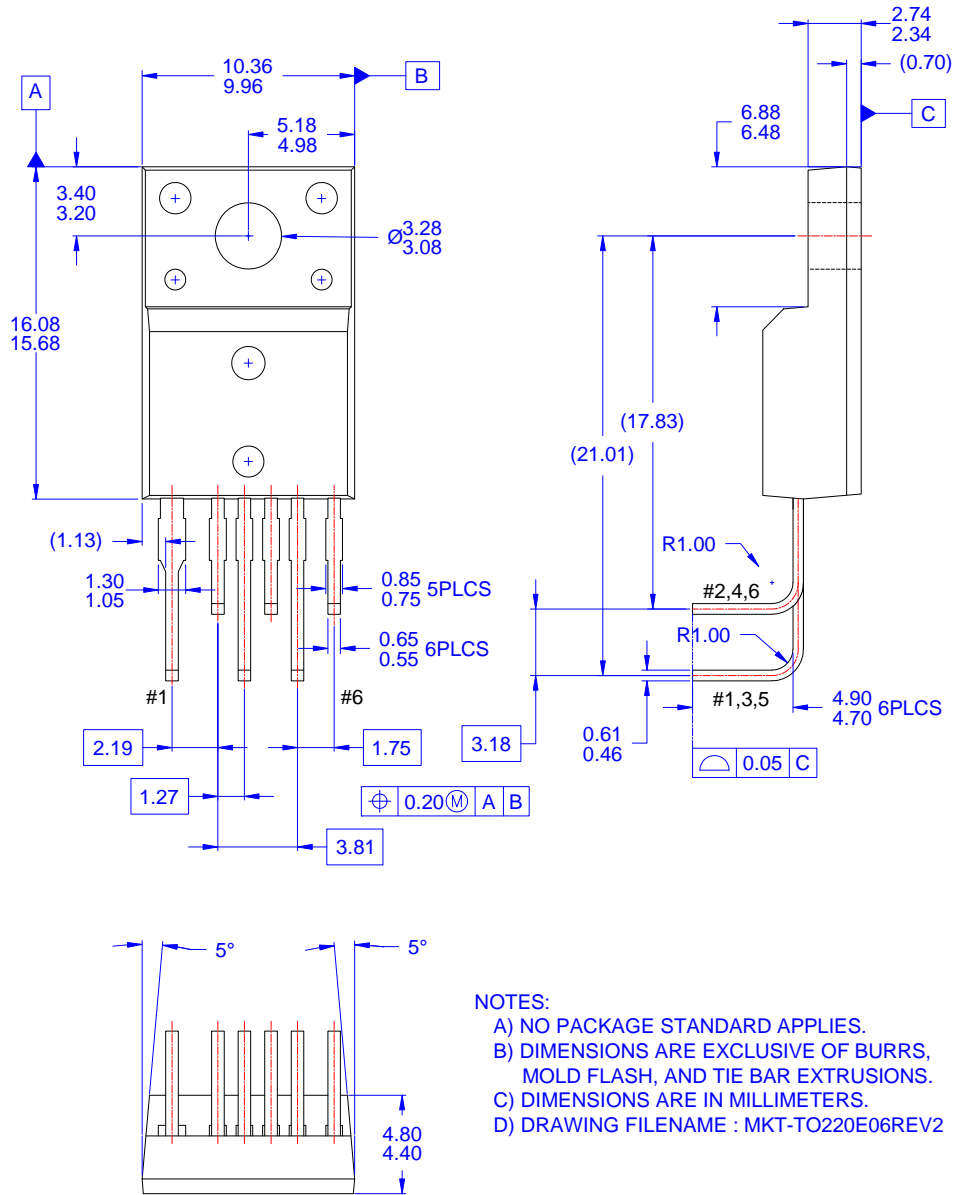
	Pin	Specification	Remarks
Inductance	1 - 3	800μH ± 10%	66kHz, 1V
Leakage	1 - 3	15μH Maximum	Short all other pins

5. Core & Bobbin

- Core: EER3016 (A_e=109.7mm²)
- Bobbin: EER3016

6. Demo Board Part List

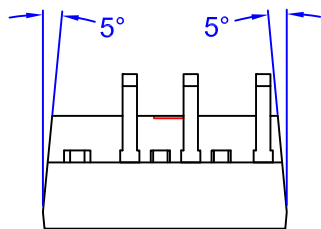
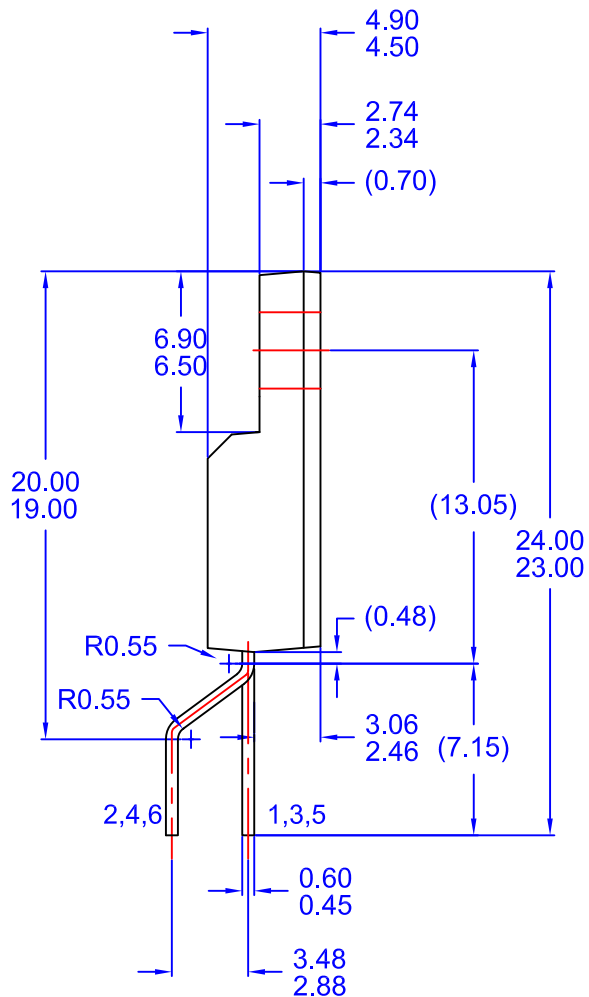
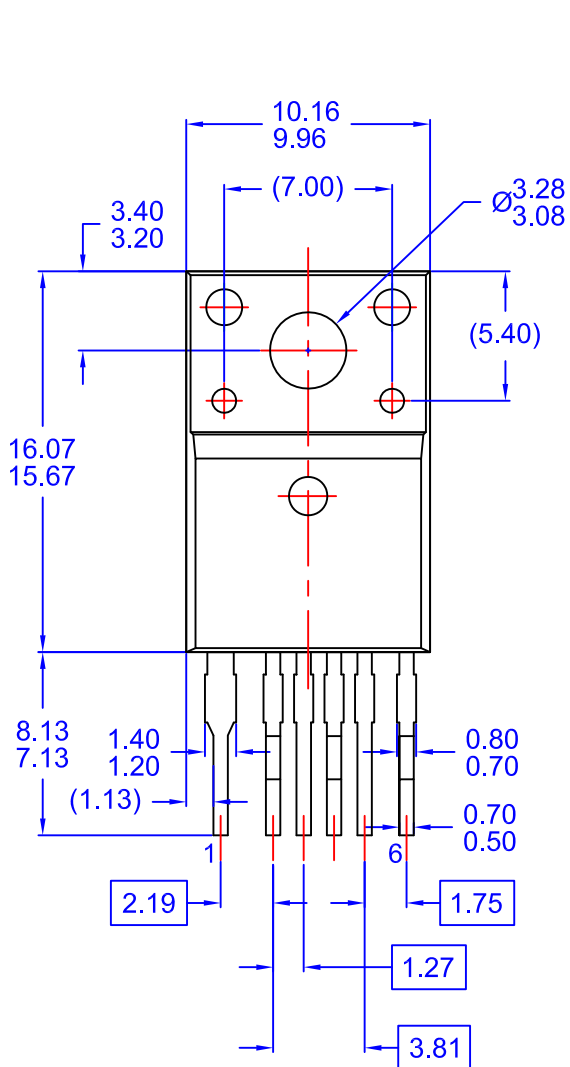
Part	Value	Note	Part	Value	Note
Resistor			C205	47nF/50V	Ceramic Capacitor
R101	1MΩ	1W	C301	4.7nF/1kV	Ceramic Capacitor
R102	68kΩ	1/2W	Inductor		
R103	33kΩ	1W	L201	5μH	5A Rating
R104	5.6Ω	1W	L202	5μH	5A Rating
R105	100Ω	<i>optional, 1/4W</i>	Diode		
R107	18kΩ	1/4W	D101	IN4007	1A, 1000V General-Purpose Rectifier
R108	12kΩ	1/4W	D102	UF4004	1A, 400V Ultrafast Rectifier
R201	1kΩ	1/4W	ZD101	1N4745A	1W 16V Zener Diode (optional)
R202	1.2kΩ	1/4W	D201	MBRF10H100	10A, 100V Schottky Rectifier
R203	10kΩ	1/4W	D202	MBRF1060	10A, 60V Schottky Rectifier
R204	5.2kΩ	1/4W	IC		
R205	4.7kΩ	1/4W	IC101	FSQ0465RS	FPS™
Capacitor			IC201	KA431 (TL431)	Voltage Reference
C101	150nF/275V _{AC}	Box Capacitor	IC202	FOD817A	Opto-Coupler
C102	150nF/275V _{AC}	Box Capacitor	Fuse		
C103	100μF/400V	Electrolytic Capacitor	Fuse	2A/250V	
C104	4.7nF/630V	Film Capacitor	NTC		
C105	33nF/50V	Ceramic Capacitor	RT101	5D-9	
C106	100nF/50V	SMD (1206)	Bridge Diode		
C107	47μF/50V	Electrolytic Capacitor	BD101	2KBP06M2N257	Bridge Diode
C201	1000μF/25V	Low-ESR Electrolytic Capacitor	Line Filter		
C202	1000μF/25V	Low-ESR Electrolytic Capacitor	LF101	34mH	
C203	1000μF/10V	Low-ESR Electrolytic Capacitor	Transformer		
C204	1000μF/10V	Low-ESR Electrolytic Capacitor	T1	EER3016	Ae=109.7mm ²



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